PY264 8K x 8 REPROGRAMMABLE PROM



FEATURES

- **EPROM Technology for reprogramming**
- High Speed
 - 35/45/55 ns (Commercial)
 - 35/45/55 ns (Military)
- **■** Low Power Operation:
 - 660 mW Commercial
 - 770 mW Military

- Single 5V±10% Power Supply
- Windowed devices for reprogramming
- **■** Fully TTL Compatible Inputs and Outputs
- Standard Pinout (JEDEC Approved):
 - 24-Pin 600 mil Windowed CERDIP
 - 24-Pin 600 mil Non-Windowed Plastic DIP



DESCRIPTION

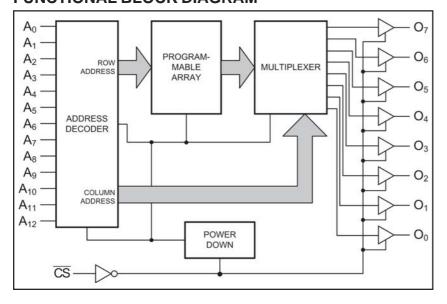
The PY264 is an 8Kx8 CMOS PROM. The device is available in windowed packages which when exposed to UV light, the memory content in the PROM is erased and can be reprogrammed. EPROM technology is used in the memory cells for programming. The EPROM requires a 12.5V for programming. Devices are tested to insure that performance of the device meets the DC and AC specification limits after customer programming.

To perform a read operation from the device, \overline{CS} is LOW. The memory contents in the address established by the Address pins (A_0 to A_{12}) will become available on the outputs (O_0 to O_2).

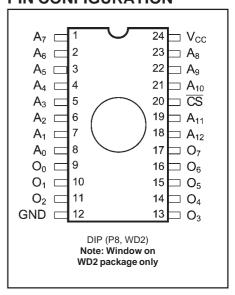
The PY264 is available in 24-pin 600 mil Ceramic DIPs (Windowed) and Plastic DIPs (Non-Windowed).



FUNCTIONAL BLOCK DIAGRAM



PIN CONFIGURATION





Document # EPROM102 REV OR



MAXIMUM RATINGS(1)

Symbol	Parameter	Value	Unit
V _{cc}	Power Supply Pin with Respect to GND	-0.5 to +7	V
V _{TERM}	Terminal Voltage with Respect to GND (up to 7.0V)	-0.5 to V _{cc} +0.5	V
V _{PP}	Program Voltage	13	V

Symbol	Parameter	Value	Unit
T _A	Operating Temperature	-55 to +125	°C
T _{BIAS}	Temperature Under Bias	-55 to +125	°C
T _{STG}	Storage Temperature	-65 to +150	°C
P _T	Power Dissipation	1.0	W
I _{OUT}	DC Output Current	50	mA

RECOMMENDED OPERATING CONDITIONS

Grade ⁽²⁾	Ambient Temp	Gnd	Vcc
Commercial	0°C to 70°C	0V	5.0V ±10%
Military	-55°C to +125°C	0V	5.0V ±10%

CAPACITANCES⁽⁴⁾

 $(V_{CC} = 5.0V, T_A = 25^{\circ}C, f = 1.0MHz)$

Symbol	Parameter	Conditions	Тур.	Unit
C _{IN}	Input Capacitance	$V_{IN} = 0V$	10	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0V	10	pF

DC ELECTRICAL CHARACTERISTICS

Over recommended operating temperature and supply voltage(2)

Symbol	Parameter	Test Conditions	PY	Unit		
Syllibol	raiailletei	rest conditions	Min	Max		
V _{IH}	Input High Voltage		2.0	V _{cc}	V	
V _{IL}	Input Low Voltage		-0.5 ⁽³⁾	0.8	V	
V _{HC}	CMOS Input High Voltage		V _{cc} -0.2	V _{cc} +0.5	V	
V _{LC}	CMOS Input Low Voltage		-0.5 ⁽³⁾	0.2	V	
V _{OL}	Output Low Voltage (TTL Load)	$I_{OL} = +16 \text{ mA}, V_{CC} = \text{Min}.$		0.4	V	
V _{OH}	Output High Voltage (TTL Load)	$I_{OH} = -4 \text{ mA}, V_{CC} = \text{Min}.$	2.4		V	
I _{LI}	Input Leakage Current	$V_{CC} = Max.$ $V_{IN} = GND \text{ to } V_{CC}$	-10	+10	μA	
I _{LO}	Output Leakage Current	$V_{CC} = Max., \overline{CE} = V_{IH},$ com	-10	+10	μΑ	
'LO	Output Loakago Outront	$V_{OUT} = GND \text{ to } V_{CC}$ MIL	-4 0	+40	μA	
V _{PP}	Programming Supply Voltage		12	13	V	
l _{PP}	Programming Supply Current			50	mA	
V _{IHP}	Input HIGH Programming Voltage		4.75		V	
V _{ILP}	Input LOW Programming Voltage			0.4	V	

POWER DISSIPATION CHARACTERISTICS VS. SPEED

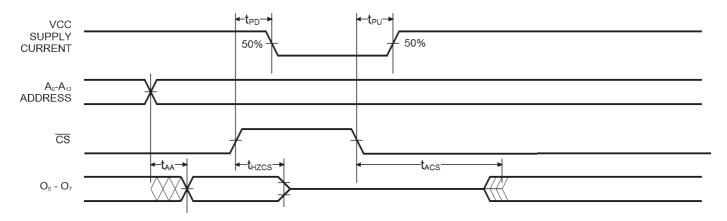
	Symbol	Parameter	Temperature Range	-35	-45	-55	Unit
Ī	1	Dynamic Operating Current*	Commercial	100	100	100	mA
	'cc	Dynamic Operating Current	Military	120	120	120	mA

AC ELECTRICAL CHARACTERISTICS—READ CYCLE

 $(V_{CC} = 5V \pm 10\%, All Temperature Ranges)^{(2)}$

Symbol	Parameter	-	35	-4	15	-5	55	Unit
Syllibol	Farameter	Min	Max	Min	Max	Min	Max	Ollit
t _{AA}	Address to Output Valid		35		45		55	ns
t _{HZCS1}	Chip Select Inactive to High Z		20		30		35	ns
t _{ACS1}	Chip Select Active to Output Valid		20		30		35	ns
t _{HZCS2}	Chip Select Inactive to High Z		35		45		55	ns
t _{ACS2}	Chip Select Active to Output Valid		35		45		55	ns
t _{PU}	Chip Select Active to Power-Up	0		0		0		ns
t _{PD}	Chip Slect Inactive to Power-Down		35		45		55	ns

TIMING WAVEFORM OF READ CYCLE



Notes:

- Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to MAXIMUM rating conditions for extended periods may affect reliability.
- 2. Extended temperature operation guaranteed with 400 linear feet per minute of air flow.
- 3. Transient inputs with V $_{\rm IL}$ and I $_{\rm IL}$ not more negative than $-3.0{\rm V}$ and $-100{\rm mA}$, respectively, are permissible for pulse widths up to 20 ns.
- 4. This parameter is sampled and not 100% tested.



DEVICE ERASURE

If the device is subjected to wavelengths of light below 4000 Angstroms, device erasure will commence. It is therefore recommended to use an opaque label over the window in the event the device will be exposed to lighting for a long time. The UV dose for erasure requires a wavelength of 2,537 Angstroms for a minimum dose of

25 Wsec/cm². If using a UV lamp of 12 mW/cm², the exposure time is estimated to be 35 minutes. Devices should be positioned within 1 inch of the lamp during the erasure process. Permanent damage can occur to the devices if exposed to UV light for an extended period of time.

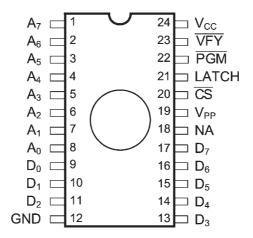
READ MODE

Reading the addressed content is the normal operating mode for a programmed device. Signals are at normal TTL levels. Addressing is applied to the 13 address pins and $\overline{\text{CS}}$ is LOW. Under these conditions, the addressed location contents are presented to the output pins.

MODE SELECTION

•		Pin Function						
Mode	Read or Output Disable	A ₁₂	A ₁₁	A ₁₀	A ₉	A ₈	CS	O ₇ -O ₀
Wiode	Program	NA	Vpp	LATCH	PGM	VFY	CS	D ₇ -D ₀
Read		A ₁₂	A ₁₁	A ₁₀	A ₉	A ₈	V_{IL}	O ₇ -O ₀
Output Disable		A ₁₂	A ₁₁	A ₁₀	A ₉	A ₈	V _{IH}	High Z
Program		V_{ILP}	Vpp	V _{ILP}	V_{ILP}	V_{IHP}	V_{ILP}	D ₇ -D ₀
Program Inhibit		V_{ILP}	Vpp	V _{ILP}	V_{IHP}	V_{IHP}	V_{ILP}	High Z
Program Verify		V_{ILP}	Vpp	V _{ILP}	V_{IHP}	V_{ILP}	V_{ILP}	O ₇ -O ₀
Blank Check		V _{ILP}	Vpp	V _{ILP}	V _{IHP}	V _{ILP}	V _{ILP}	O ₇ -O ₀

PROGRAMMING PINOUTS



AC TEST CONDITIONS

Input Pulse Levels	GND to 3.0V
Input Rise and Fall Times	3ns
Input Timing Reference Level	1.5V
Output Timing Reference Level	1.5V
Output Load	See Figures 1 and 2

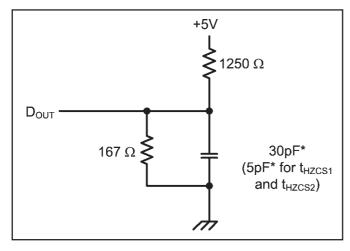


Figure 1. Output Load

Note

Because of the ultra-high speed of the PY264, care must be taken when testing this device; an inadequate setup can cause a normal functioning part to be rejected as faulty. Long high-inductance leads that cause

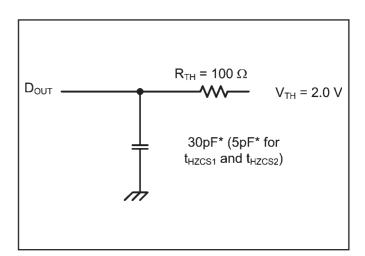


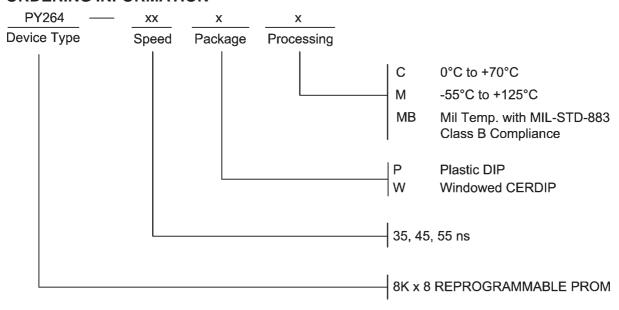
Figure 2. Thevenin Equivalent

supply bounce must be avoided by bringing the $V_{\rm CC}$ and ground planes directly up to the contactor fingers. A 0.01 μF high frequency capacitor is also required between $V_{\rm CC}$ and ground.

^{*} including scope and test fixture.



ORDERING INFORMATION



SELECTION GUIDE

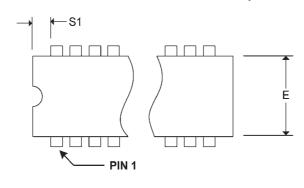
The PY264 is available in the following temperature, speed and package options.

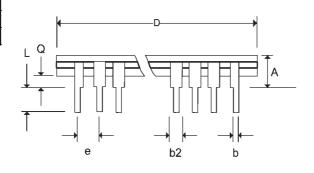
Temperature	Poekogo			
Range	Package	35	45	55
Commercial	Plastic DIP	-35PC	N/A	N/A
	Windowed CERDIP	N/A	-45WC	-55WC
Military Temperature	Windowed CERDIP	N/A	-45WM	-55WM
Military Processed*	Windowed CERDIP	N/A	-45WMB	-55WMB

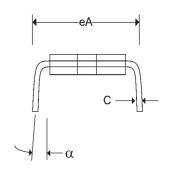
^{*} Military temperature range with MIL-STD-883, Class B processing. N/A = Not Available

Pkg#	WD2					
# Pins	24 (600 mil)					
Symbol	Min	Max				
Α	0.175	0.225				
b	0.015	0.020				
b2	0.045	0.065				
С	0.009	0.012				
D	-	1.280				
Е	0.505	0.550				
eA	0.600	BSC				
е	0.100	BSC				
L	0.125	0.200				
Q	0.015	0.060				
S1	0.005	-				
α	0° 15°					
WD	0.280					

CERAMIC DUAL IN-LINE PACKAGE (WINDOWED)

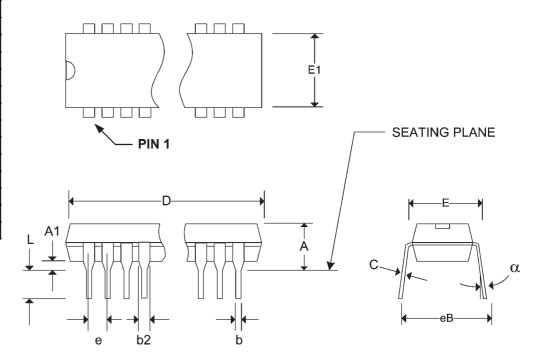






Pkg #	P8				
# Pins	24 (60	00 mil)			
Symbol	Min	Max			
Α	0.155	0.200			
A1	0.015	0.060			
b	0.015	0.020			
b2	0.055	0.065			
С	0.009	0.012			
D	1.230	1.260			
E1	0.530	0.550			
E	0.570	0.625			
е	0.100	BSC			
eB	0.610	0.685			
L	0.115	0.160			
α	0° 15°				

PLASTIC DUAL IN-LINE PACKAGE (NON-WINDOWED)



REVISIONS

DOCUMENT NUMBER: DOCUMENT TITLE:		EPROM PY264 8I	102 < x 8 REPROGRAMMABLE PROM
REV.	ISSUE DATE	ORIG. OF CHANGE	DESCRIPTION OF CHANGE
OR	Jul-2007	JDB	New Data Sheet